

IRFH5010TR2PBF-VB Datasheet N-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{(BR)DSS} (V)	$r_{DS(on)}(\Omega)$	I _D (A)		
100	0.006 at V _{GS} = 10 V	95		

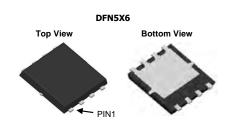
FEATURES

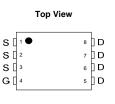
- TrenchFET® Power MOSFET
- 175 °C Junction Temperature
- Low Thermal Resistance Package
- 100 % R_g Tested

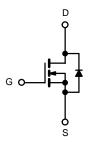


APPLICATIONS

• Isolated DC/DC Converters







N-Channel MOSFET

ABSOLUTE MAXIMUM RATING	iS (T _A = 25 °C, u	ınless otherv	wise noted)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V_{DS}	100	V	
Gate-source voltage		V_{GS}	± 20	v	
	T _C = 25 °C		95		
Continuous dusin surrent (T. 150 °C)	T _C = 70 °C	1 .	85		
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	l _D	30 b, c		
	T _A = 70 °C		25.5 ^{b, c}	•	
Pulsed drain current (t = 100 µs)		I _{DM}	250	— A	
Continuous source-drain diode current	T _C = 25 °C		70		
	T _A = 25 °C	I _S	6.8 b, c		
Single pulse avalanche current		I _{AS}	38		
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	50	mJ	
	T _C = 25 °C		100		
Manipular and a discipation	T _C = 70 °C		70	w	
Maximum power dissipation	T _A = 25 °C	P _D	6 b, c	VV	
	T _A = 70 °C		4.2 ^{b, c}		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) ^c			260	-0	

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient b	t ≤ 10 s	R _{thJA}	20	25	°C/W		
Maximum junction-to-case (drain)	Steady state	R_{thJC}	1.6	2]		

Notes

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static					•	
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	81	-	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-7.5	-	mV/°(
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	-	5	V
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA
Zove gete veltege dyein erwent		V _{DS} = 100 V, V _{GS} = 0 V	-	-	1	μА
Zero gate voltage drain current	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V, T _J = 70 °C	-	-	15	
On-state drain current ^a	I _{D(on)}	$V_{DS} \geq 10~V,~V_{GS} = 10~V$	60	-	-	Α
Drain-source on-state resistance ^a	В	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	-	0.006	-	Ω
Drain-source on-state resistance	R _{DS(on)}	$V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	-	0.008	-	
Forward transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_D = 10 \text{ A}$	-	46	-	S
Dynamic ^b						
Input capacitance	C _{iss}		1	6500	-	pF
Output capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	132	-	
Reverse transfer capacitance	C _{rss}		-	11.2	-	
Total gate charge	Qg	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$	ı	20	-	nC
			-	15	-	
Gate-source charge	Q_{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	ı	6.45	-	
Gate-drain charge	Q_{gd}		ı	3.5	-	
Output charge	Q _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$	ı	22	-	
Gate resistance	R_g	f = 1 MHz	0.2	0.76	1.4	Ω
Turn-on delay time	t _{d(on)}		ı	12	24	
Rise time	t _r	$V_{DD} = 50 \text{ V}, \text{ R}_L = 5 \Omega, \text{ I}_D \cong 10 \text{ A},$	ı	5	10	
Turn-off delay time	t _{d(off)}	V_{GEN} = 10 V, R_g = 1 Ω	1	19	38	
Fall time	t _f		ı	5	10	ns
Turn-on delay time	t _{d(on)}		-	15	30	118
Rise time	t _r	V_{DD} = 50 V, R_L = 5 Ω , I_D \cong 10 A,		6	12	
Turn-off delay time	t _{d(off)}	V_{GEN} = 7.5 V, R_g = 1 Ω	-	19	38	
Fall time	t _f		-	5	10	
Drain-Source Body Diode Characteris	tics					
Continuous source-drain diode current	Is	T _C = 25 °C	-	-	70	A
Pulse diode forward current	I _{SM}		-	-	80] A
Body diode voltage	V _{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.78	1.1	V
Body diode reverse recovery time	t _{rr}		-	43	86	ns
Body diode reverse recovery charge	Q _{rr}	1 10 A di/d+ 100 A/ T 05 00	-	72	144	nC
Reverse recovery fall time	ta	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	33	-	ns
Reverse recovery rise time	t _b		-	10	-	

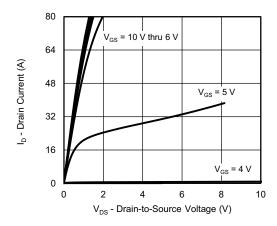
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,\,duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

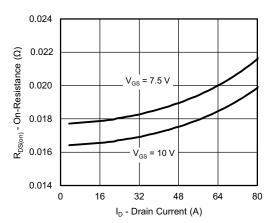
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



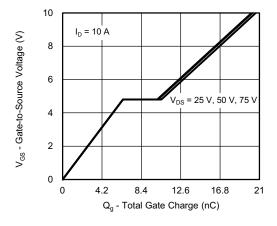
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



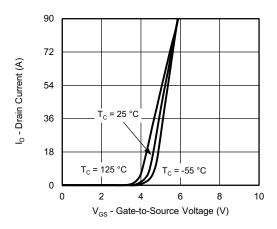
Output Characteristics



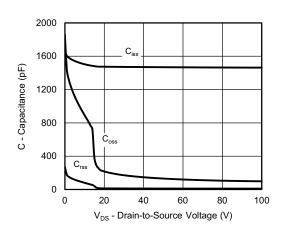
On-Resistance vs. Drain Current and Gate Voltage



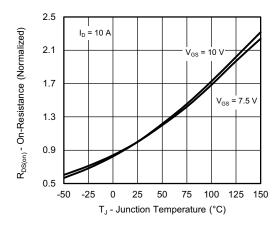
Gate Charge



Transfer Characteristics



Capacitance



On-Resistance vs. Junction Temperature

0.10

0.08

0.06

0.04

0.02

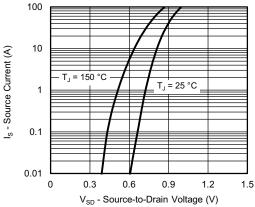
0

2

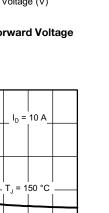
R_{DS(on)} - On-Resistance (Ω)



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Source-Drain Diode Forward Voltage

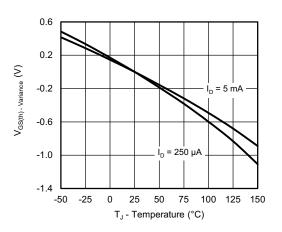


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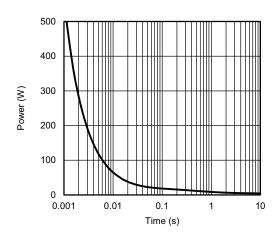
On-Resistance vs. Gate-to-Source Voltage

V_{GS} - Gate-to-Source Voltage (V)

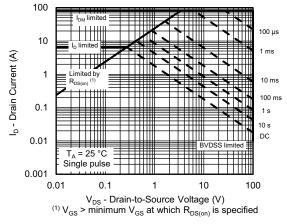
T_J = 25 °C



Threshold Voltage



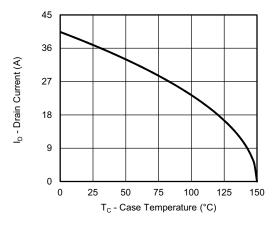
Single Pulse Power, Junction-to-Ambient



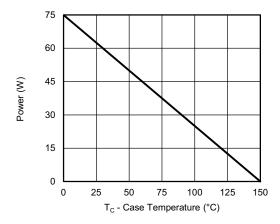
Safe Operating Area, Junction-to-Ambient

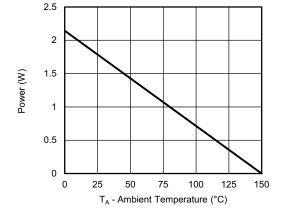


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating ^a





Power, Junction-to-Case

Power, Junction-to-Ambient

Note

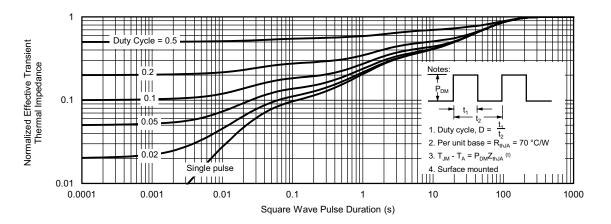
a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

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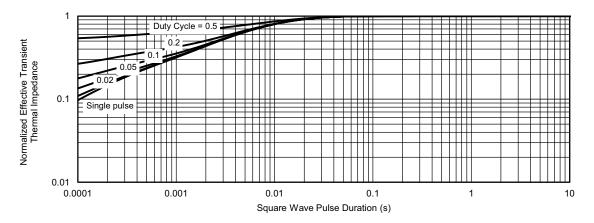
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



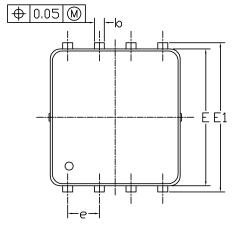
Normalized Thermal Transient Impedance, Junction-to-Ambient

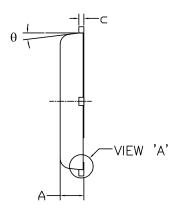


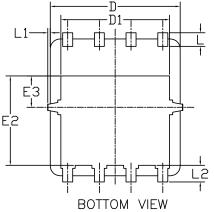
Normalized Thermal Transient Impedance, Junction-to-Case

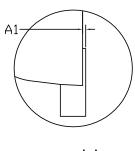


DFN5x6_8L_EP1_P PACKAGE OUTLIN



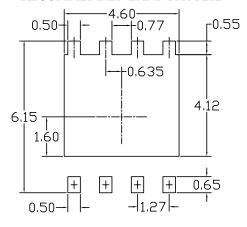






<u>VIEW 'A'</u> (SCALE 5:1)

RECOMMENDED LAND PATTERN



SYMBOLS DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
3 I MBOLS	MIN	NOM	MAX	MIN	NOM	MAX
A	0.85	0. 95	1.00	0.033	0.037	0.039
Al	0.00		0.05	0.000		0.002
b	0.30	0.40	0.50	0.012	0.016	0.020
c	0.15	0. 20	0. 25	0.006	0.008	0.010
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209
D1	4. 25	4. 35	4. 45	0. 167	0.171	0. 175
Е	5. 45	5. 55	5. 65	0. 215	0.219	0. 222
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242
E2	3. 525	3.625	3. 725	0.139	0. 143	0. 147
E3	1. 175	1. 275	1.375	0.046	0.050	0.054
e	1. 27 BSC			0.050 BSC		
L	0.45	0. 55	0.65	0.018	0.022	0.026
L1	0		0. 15	0		0.006
L2	0.68 REF		0.027 REF			
θ	0°		10°	0°		10°

NOTE

- UNIT: mm
- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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